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Examiner

Tuan H. Nguyen

Applicant(s)/Patent under Reexamination

NAKAJIMA ET AL.

Art Unit

2813

SEARCHED						
Class	Subclass	Date	Examiner			
438	151	4/27/2005	TN			
	153					
	162					
	166					
	471					
	476					

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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East	4/28/2005	TN		
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